

P2.2: Epitaxial growth of LaCoO₃ thin films by MBE.

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P2.6: Growth and analysis of InAs/ZnTe core-shell nanowires for superconductivity applications.

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P2.8: Growth of MoS₂ on GaN/Sapphire Substrates Using Molecular Beam Epitaxy.

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P2.10: High electron mobility in in-plane InAs/GaSb core-shell nanowires: growth, characterization, and magneto-transport properties.

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P2.12: Hysteresis $\beta \Leftrightarrow \beta'$ phase transition in the In₂Se₃ film.

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P2.14: InAs/GaAs Heterostructure Nanowires with Phase-Change Materials for Single-Photon Sources.

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P2.16: MBE-grown AlN nanowires for 235 nm LEDs realization.

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P2.18: Optimizing Zincblende InP nanowires morphology with embedded InAs_xP_{1-x} QDs for high emission extraction efficiency at telecom wavelengths.

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P2.20: RHEED oscillation decay and signal recovery in nucleation and step flow growth.

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P2.22: Threading and misfit dislocations study by Electron Channeling Contrast Imaging.

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P2.24: A Surface X-Ray Diffraction Investigation on the 2×1 Surface Reconstruction of Bismuth on GaAs (001).

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P2.26: Anomalous growth of epitaxial silicene on graphene : a kinetic Monte-Carlo approach.

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P2.28: Controllable Branching of Self-Catalysed AlGaAs Nanowires Synthesised via Molecular Beam Epitaxy.

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P2.30: Drastic enhancement of the internal quantum efficiency of thick (In,Ga)N layers by thermal annealing.

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P2.32: Influence of High-temperature annealing on MBE-grown AlN thin film layers.

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P2.34: Kinetic monte carlo simulation of GaAs growth on (001) silicon.

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P2.36: Segregation-Driven Formation of Bismuth Quantum Dots in GaAsBi Layers and Quantum Structures.

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P2.38: Surface processes on Bi₂Se₃(0001) during indium deposition studied by in situ reflection electron microscopy.

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P2.40: Tuning the Diameter of GaAs Nanowires by Wet Chemical Etching. J.Pelenc , P. Regreny, C.

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P2.42: Growth of Superconducting Sr₂RuO₄ Thin Films via Thermal Laser Epitaxy.

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P2.44: Optimizing thermal management of equipment used in MBE/PVD-processes via simulation.

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